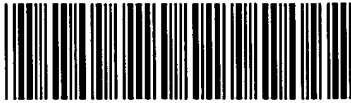


**Search Notes**

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09/754,802

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Soon D. Hyun

Applicant(s)/Patent under  
Reexamination

ENOKI ET AL.

Art Unit

2661

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference search-see printout		12/19/2005	HY

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/254-258,389, 400,401; text search only-see search history printout	12/18/2005	HY